
PART NUMBER**54H73JC-ROCV**

**Rochester Electronics
Manufactured Components**

Rochester branded components are manufactured using either die/wafers purchased from the original suppliers or Rochester wafers recreated from the original IP. All re-creations are done with the approval of the Original Component Manufacturer. (OCM)

Parts are tested using original factory test programs or Rochester developed test solutions to guarantee product meets or exceeds the OCM data sheet.

Quality Overview

- ISO-9001
- AS9120 certification
- Qualified Manufacturers List (QML) MIL-PRF-38535
 - Class Q Military
 - Class V Space Level

Qualified Suppliers List of Distributors (QSLD)

- Rochester is a critical supplier to DLA and meets all industry and DLA standards.

Rochester Electronics, LLC is committed to supplying products that satisfy customer expectations for quality and are equal to those originally supplied by industry manufacturers.

The original manufacturer's datasheet accompanying this document reflects the performance and specifications of the Rochester manufactured version of this device. Rochester Electronics guarantees the performance of its semiconductor products to the original OCM specifications. 'Typical' values are for reference purposes only. Certain minimum or maximum ratings may be based on product characterization, design, simulation, or sample testing.

54H73, 54L73

Dual J-K Flip-Flops with Clear

The 'H73, and 'L73 contain two independent J-K flip-flops with individual J-K, clock, and direct clear inputs. J-K input is loaded into the master while the clock is high and transferred to the slave on the high-to-low transition. For these devices the J and K inputs must be stable while the clock is high.

The SN54H73, SN54L73, and the SN54LS73A are characterized for operation over the full military temperature range of -55°C to 125°C.

Rochester Electronics Manufactured Components

Rochester branded components are manufactured using either die/wafers purchased from the original suppliers or Rochester wafers recreated from the original IP. All re-creations are done with the approval of the Original Component Manufacturer (OCM).

Parts are tested using original factory test programs or Rochester developed test solutions to guarantee product meets or exceeds the OCM data sheet.

Quality Overview

- ISO-9001
- AS9120 certification
- Qualified Manufacturers List (QML) MIL-PRF-35835
 - Class Q Military
 - Class V Space Level
- Qualified Suppliers List of Distributors (QSLD)
 - Rochester is a critical supplier to DLA and meets all industry and DLA standards.

Rochester Electronics, LLC is committed to supplying products that satisfy customer expectations for quality and are equal to those originally supplied by industry manufacturers.

The original manufacturer's datasheet accompanying this document reflects the performance and specifications of the Rochester manufactured version of this device. Rochester Electronics guarantees the performance of its semiconductor products to the original OCM specifications. 'Typical' values are for reference purposes only. Certain minimum or maximum ratings may be based on product characterization, design, simulation, or sample testing.

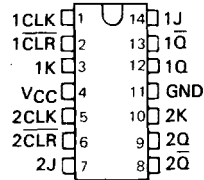
FOR REFERENCE ONLY

TYPES SN5473, SN54H73, SN54L73, SN54LS73A, SN7473, SN74H73, SN74LS73A DUAL J-K FLIP-FLOPS WITH CLEAR

REVISED DECEMBER 1983

- Package Options Include Plastic and Ceramic DIPs
- Dependable Texas Instruments Quality and Reliability

SN5473, SN54H73, SN54LS73A ... J OR W PACKAGE
SN54L73 ... J PACKAGE
SN7473, SN74H73 ... J OR N PACKAGE
SN74LS73A ... D, J OR N PACKAGE
(TOP VIEW)



'73, 'H73, 'L73
FUNCTION TABLE

INPUTS				OUTPUTS	
CLR	CLK	J	K	Q	Q̄
L	X	X	X	L	H
H	↓	L	L	Q ₀	Q̄ ₀
H	↓	H	L	H	L
H	↓	L	H	L	H
H	↓	H	H	TOGGLE	

'LS73A
FUNCTION TABLE

INPUTS				OUTPUTS	
CLR	CLK	J	K	Q	Q̄
L	X	X	X	L	H
H	↓	L	L	Q ₀	Q̄ ₀
H	↓	H	L	H	L
H	↓	L	H	L	H
H	↓	H	H	TOGGLE	
H	H	X	X	Q ₀	Q̄ ₀

FOR CHIP CARRIER INFORMATION,
CONTACT THE FACTORY

description

The '73, 'H73, and 'L73 contain two independent J-K flip-flops with individual J-K, clock, and direct clear inputs. The '73, 'H73, and 'L73 are positive pulse-triggered flip-flops. J-K input is loaded into the master while the clock is high and transferred to the slave on the high-to-low transition. For these devices the J and K inputs must be stable while the clock is high.

The 'LS73A contain two independent negative-edge-triggered flip-flops. The J and K inputs must be stable one setup time prior to the high-to-low clock transition for predictable operation. When the clear is low, it overrides the clock and data inputs forcing the Q output low and the Q̄ output high.

The SN5473, SN54H73, SN54L73, and the SN54LS73A are characterized for operation over the full military temperature range of -55°C to 125°C. The SN7473, SN74H73, and the SN74LS73A are characterized for operation from 0°C to 70°C.

3

TTL DEVICES

TEXAS
INSTRUMENTS

POST OFFICE BOX 225012 • DALLAS TEXAS 75265

3-285

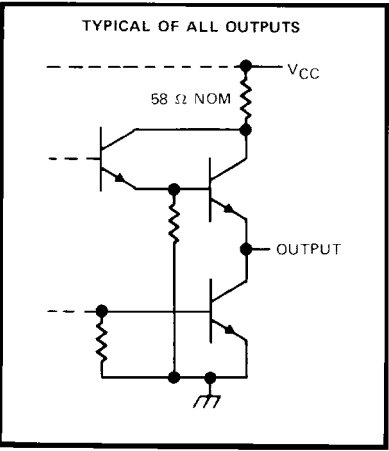
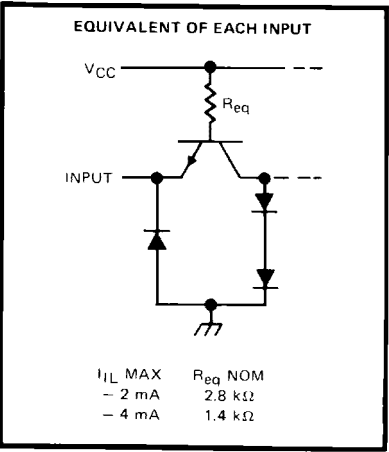
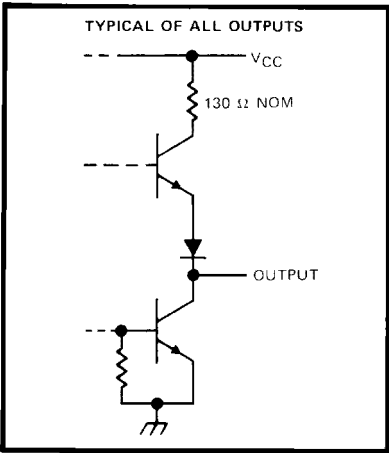
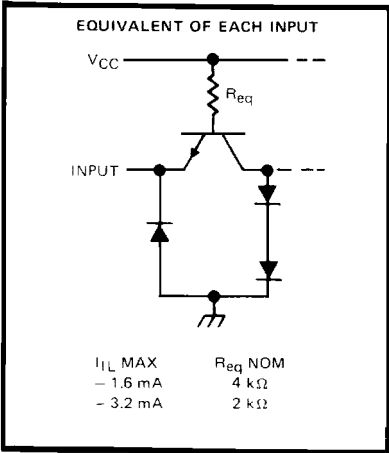
TYPES SN5473, SN54H73, SN54L73, SN54LS73A,
 SN7473, SN74H73, SN74LS73A
 DUAL J-K FLIP-FLOPS WITH CLEAR

logic symbols



Pin numbers shown on logic notation are for D, J or N packages.

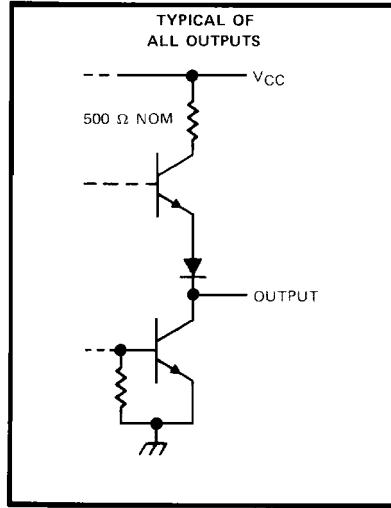
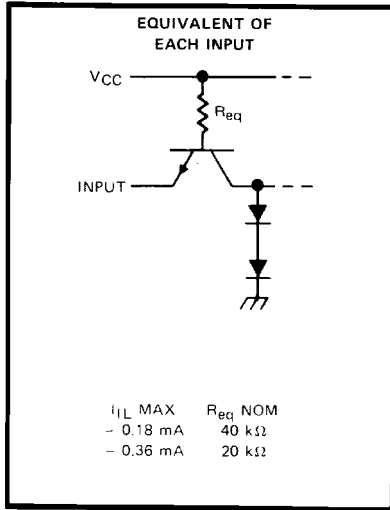
schematics of inputs and outputs



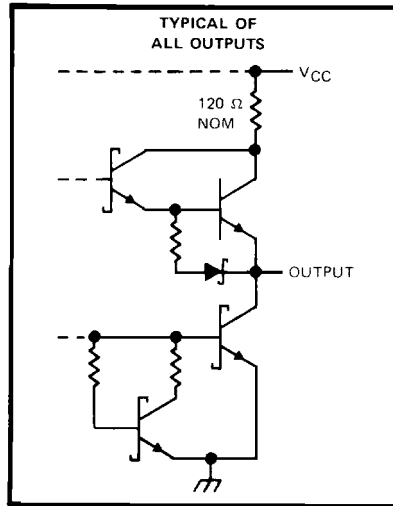
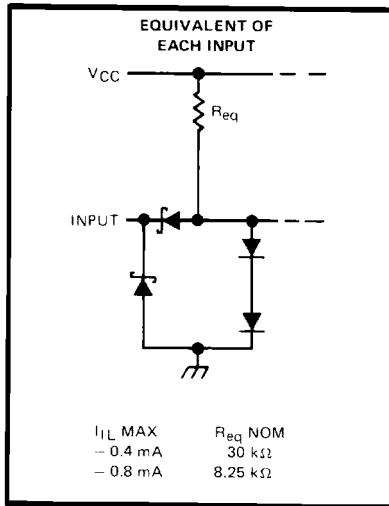
TYPES SN54L73, SN54LS73A, SN74LS73A
DUAL J-K FLIP-FLOPS WITH CLEAR

schematics of inputs and outputs (continued)

'L73



'LS73A

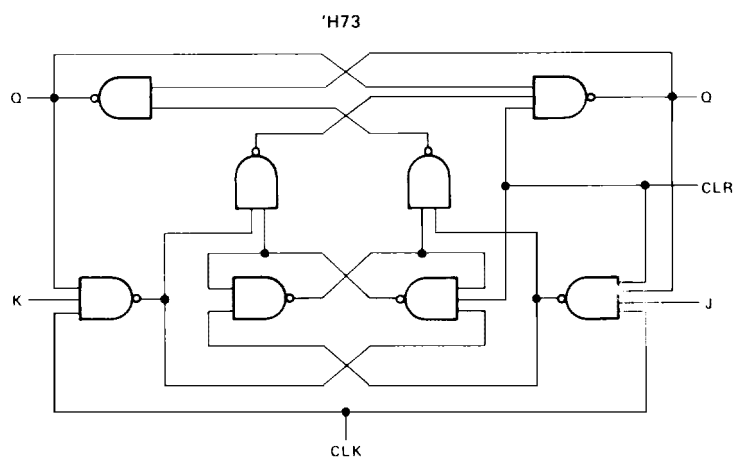
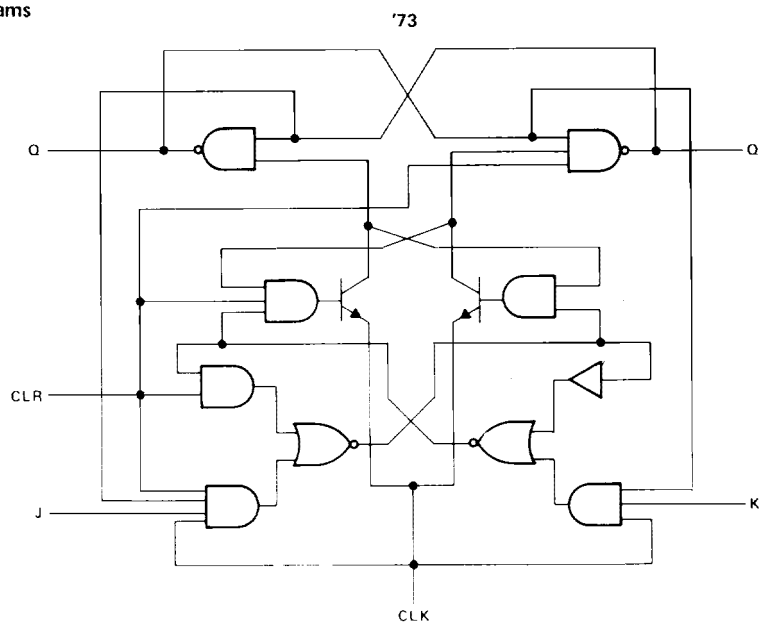


3

TTL DEVICES

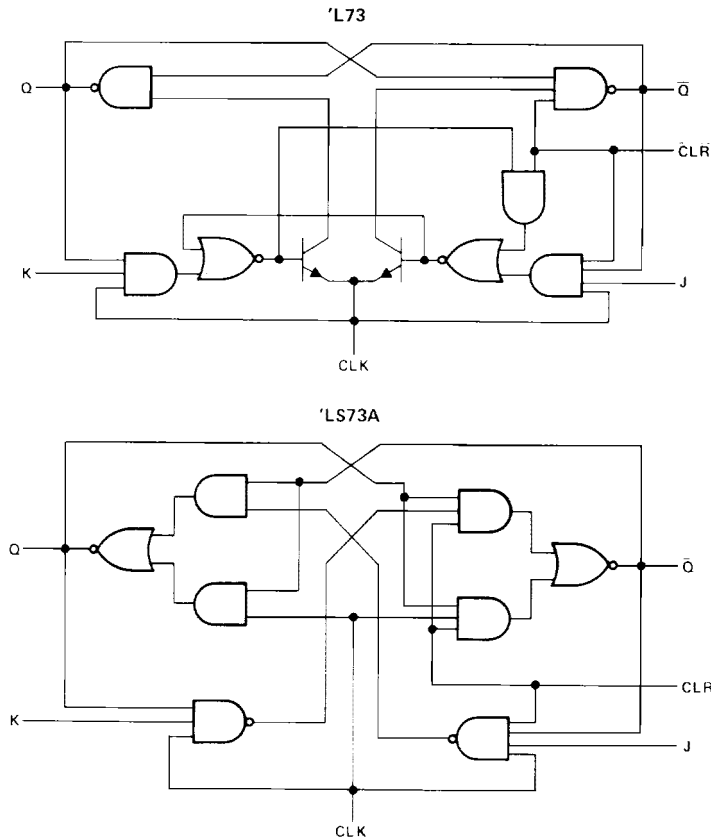
TYPES SN5473, SN54H73, SN7473, SN74H73
DUAL J-K FLIP-FLOPS WITH CLEAR

logic diagrams



TYPES SN5473, SN54H73, SN54L73, SN54LS73A,
SN7473, SN74H73, SN74LS73A
DUAL J-K FLIP-FLOPS WITH CLEAR

logic diagrams (continued)



3

TTL DEVICES

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V_{CC} (see Note 1)	7 V
Input voltage: '73, 'H73, 'L73	5.5 V
'LS73A	7 V
Operating free-air temperature range: SN54'	-55°C to 125°C
SN74'	0°C to 70°C
Storage temperature range	-65°C to 150°C

NOTE 1: Voltage values are with respect to network ground terminal.

TYPES SN5473, SN7473

DUAL J-K FLIP-FLOPS WITH CLEAR

recommended operating conditions

			SN5473			SN7473			UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage		4.5	5	5.5	4.75	5	5.25	V
V_{IH}	High-level input voltage		2			2			V
V_{IL}	Low-level input voltage				0.8			0.8	V
I_{OH}	High-level output current				− 0.4			− 0.4	mA
I_{OL}	Low-level output current				16			16	mA
t_w	Pulse duration	CLK high	20			20			ns
		CLK low	47			47			
		CLR low	25			25			
t_{su}	Input setup time before CLK †		0			0			ns
t_h	Input hold time data after CLK †		0			0			ns
T_A	Operating free-air temperature		− 55			125			°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS†			SN5473			SN7473			UNIT
					MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}		$V_{CC} = \text{MIN}, I_I = -12 \text{ mA}$					-1.5			-1.5	V
V_{OH}		$V_{CC} = \text{MIN}, V_{IH} = 2 \text{ V}, V_{IL} = 0.8 \text{ V}, I_{OH} = -0.4 \text{ mA}$			2.4	3.4		2.4	3.4		V
V_{OL}		$V_{CC} = \text{MIN}, V_{IH} = 2 \text{ V}, V_{IL} = 0.8 \text{ V}, I_{OL} = 16 \text{ mA}$				0.2	0.4		0.2	0.4	V
I_I		$V_{CC} = \text{MAX}, V_I = 5.5 \text{ V}$					1			1	mA
I_{IH}	J or K	$V_{CC} = \text{MAX}, V_I = 2.4 \text{ V}$					40			40	μA
	CLR or CLK						80			80	
I_{IL}	J or K	$V_{CC} = \text{MAX}, V_I = 0.4 \text{ V}$					-1.6			-1.6	mA
	CLR						-3.2			-3.2	
	CLK						-3.2			-3.2	
$I_{OS}§$		$V_{CC} = \text{MAX}$			-20	-57		-18	-57		mA
I_{CC}		$V_{CC} = \text{MAX}, \text{ See Note 2}$				10	20		10	20	mA

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values are at $V_{CC} = 5 \text{ V}, T_A = 25^\circ\text{C}$.

§ Not more than one output should be shorted at a time.

NOTE 2: With all outputs open, I_{CC} is measured with the Q and Q outputs high in turn. At the time of measurement, the clock input is grounded.

switching characteristics, $V_{CC} = 5 \text{ V}, T_A = 25^\circ\text{C}$ (see note 3)

PARAMETER¶	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
f_{max}			$R_L = 400 \Omega, C_L = 15 \text{ pF}$	15	20		MHz
t_{PLH}	CLR	0			16	25	ns
t_{PHL}		Q			25	40	ns
t_{PLH}	CLK	Q or Q			16	25	ns
t_{PHL}		Q or Q			25	40	ns

¶ f_{max} = maximum clock frequency; t_{PLH} = propagation delay time, low-to-high-level output; t_{PHL} = propagation delay time, high-to-low-level output.

NOTE 3: See General Information Section for load circuits and voltage waveforms.

TYPES SN54H73, SN74H73 DUAL J-K FLIP-FLOPS WITH CLEAR

recommended operating conditions

		SN54H73			SN74H73			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
V _{CC}	Supply voltage	4.5	5	5.5	4.75	5	5.25	V
V _{IH}	High-level input voltage	2			2			V
V _{IL}	Low-level input voltage			0.8			0.8	V
I _{OH}	High-level output current			− 0.5			− 0.5	mA
I _{OL}	Low-level output current			20			20	mA
t _w	Pulse duration	CLK high			12			ns
		CLK low			28			
		CLR low			16			
t _{su}	Input setup time before CLK †	High-level data			0			ns
		Low-level data			0			
t _h	Input hold time, data after CLK †	0			0			ns
T _A	Operating free-air temperature	− 55			125			°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS†		SN54H73			SN74H73			UNIT
				MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V _{IK}		V _{CC} = MIN, I _I = − 8 mA				− 1.5			− 1.5	V
V _{OH}		V _{CC} = MIN, V _{IH} = 2 V, V _{IL} = 0.8 V, I _{OH} = − 0.5 mA		2.4	3.4		2.4	3.4		V
V _{OL}		V _{CC} = MIN, V _{IH} = 2 V, V _{IL} = 0.8 V, I _{OL} = 20 mA			0.2	0.4		0.2	0.4	V
I _I		V _{CC} = MAX, V _I = 5.5 V				1			1	mA
I _{IH}	J, K, or CLK	V _{CC} = MAX, V _I = 2.4 V				50			50	µA
	CLR					100			100	
I _{IL}	J, K, or CLK	V _{CC} = MAX, V _I = 0.4 V				− 2			− 2	mA
	CLR					− 4			− 4	
I _{OS} §		V _{CC} = MAX		− 40		− 100	− 40		− 100	mA
I _{CC}		V _{CC} = MAX, See Note 2				16			25	mA

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values are at V_{CC} = 5 V, T_A = 25°C.

§ Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second.

NOTE 2: With all outputs open, I_{CC} is measured with the Q and $\bar{Q}$ outputs high in turn. At the time of measurement, the clock input is grounded.

switching characteristics, V_{CC} = 5 V, T_A = 25°C (see note 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t _{max}			R _L = 280 Ω, C _L = 25 pF	25	30		MHz
t _{PLH}	CLR	$\bar{Q}$			6	13	ns
t _{PHL}		Q			12	24	ns
t _{PLH}		Q or $\bar{Q}$			14	21	ns
t _{PHL}	CLK	Q or $\bar{Q}$			22	27	ns

NOTE 3: See General Information Section for load circuits and voltage waveforms

3
TTL DEVICES

TYPE SN54L73

DUAL J-K FLIP-FLOPS WITH CLEAR

recommended operating conditions

		MIN	NOM	MAX	UNIT
V_{CC}	Supply voltage	4.5	5	5.5	V
V_{IH}	High-level input voltage	2			V
V_{IL}	Low-level input voltage	Clock input		0.6	V
		All other inputs		0.7	
I_{OH}	High-level output current			-0.1	mA
I_{OL}	Low-level output current			2	mA
t_w	Pulse duration	CLK high or low		200	ns
		CLR low		100	
t_{su}	Setup time before CLK $\dagger$		0		ns
t_h	Hold time-data after CLK $\dagger$		0		ns
T_A	Operating free-air temperature	-55		125	$^{\circ}\text{C}$

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS $\dagger$	MIN	TYP $\ddagger$	MAX	UNIT
V_{OH}	$V_{CC} = \text{MIN}, V_{IH} = 2\text{ V}, V_{IL} = \text{MAX}, I_{OH} = -0.1\text{ mA}$	2.4	3.3		V
V_{OL}	$V_{CC} = \text{MIN}, V_{IH} = 2\text{ V}, V_{IL} = \text{MAX}, I_{OL} = 2\text{ mA}$		0.15	0.3	V
I_I	J or K	$V_{CC} = \text{MAX}, V_I = 5.5\text{ V}$		0.1	mA
	CLR or CLK			0.2	
I_{IH}	J or K	$V_{CC} = \text{MAX}, V_I = 2.4\text{ V}$		10	μA
	CLR			20	
	CLK			-200	
I_{IL}	J or K	$V_{CC} = \text{MAX}, V_I = 0.3\text{ V}$		-0.18	mA
	CLR or CLK			-0.36	
I_{OS}	$V_{CC} = \text{MAX}$	-3		-15	mA
I_{CC}	$V_{CC} = \text{MAX}, \text{ See Note 2}$		0.76	1.44	mA

$\dagger$ For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

$\ddagger$ All typical values are at $V_{CC} = 5\text{ V}, T_A = 25^{\circ}\text{C}$.

NOTE 2: With all outputs open, I_{CC} is measured with the Q and $\bar{Q}$ outputs high in turn. At the time of measurement, the clock input is grounded.

switching characteristics, $V_{CC} = 5\text{ V}, T_A = 25^{\circ}\text{C}$ (see note 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT	
t_{max}			$R_L = 4\text{ k}\Omega, \quad C_L = 50\text{ pF}$	2.5	3		MHz	
t_{PLH}	CLR	Q or $\overline{Q}$			35	75	ns	
t_{PHL}	CLR (CLK high)	$\overline{Q}$ or Q			60	150	ns	
	CLR (CLK low)					200		
t_{PLH}	CLK	Q or $\overline{Q}$			10	35	75	ns
t_{PHL}					10	60	150	ns

NOTE 3: See General Information Section for load circuits and voltage waveforms.

TYPES SN54LS73A, SN74LS73A DUAL J-K FLIP-FLOPS WITH CLEAR

recommended operating conditions

			SN54LS73A			SN74LS73A			UNIT
			MIN	NOM	MAX	MIN	NOM	MAX	
V _{CC}	Supply voltage		4.5	5	5.5	4.75	5	5.25	V
V _{IH}	High-level input voltage		2			2			V
V _{IL}	Low-level input voltage				0.7			0.8	V
I _{OH}	High-level output current				- 0.4			- 0.4	mA
I _{OL}	Low-level output current				4			8	mA
f _{clock}	Clock frequency		0		30	0		30	MHz
t _w	Pulse duration	CLK high	20			20			ns
		CLR low	25			20			
t _{su}	Set up time-before CLK ↓	data high or low	20			20			ns
		CLR inactive	20			20			
t _h	Hold time-data after CLK ↓		0			0			ns
T _A	Operating free-air temperature		- 55			125			°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS†		SN54LS73A			SN74LS73A			UNIT
				MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V_{IK}		$V_{CC} = \text{MIN}, I_I = -18 \text{ mA}$				-1.5			-1.5	V
V_{OH}		$V_{CC} = \text{MIN}, V_{IH} = 2 \text{ V}, V_{IL} = \text{MAX}, I_{OH} = -0.4 \text{ mA}$		2.5	3.4		2.7	3.4		V
V_{OL}		$V_{CC} = \text{MIN}, V_{IL} = \text{MAX}, V_{IH} = 2 \text{ V}, I_{OL} = 4 \text{ mA}$			0.25	0.4		0.25	0.4	V
		$V_{CC} = \text{MIN}, V_{IL} = \text{MAX}, V_{IH} = 2 \text{ V}, I_{OL} = 8 \text{ mA}$						0.35	0.5	
I_I	J or K	$V_{CC} = \text{MAX}, V_I = 7 \text{ V}$				0.1			0.1	mA
	CLR					0.3			0.3	
	CLK					0.4			0.4	
I_{IH}	J or K	$V_{CC} = \text{MAX}, V_I = 2.7 \text{ V}$				20			20	µA
	CLR					60			60	
	CLK					80			80	
I_{IL}	J or K	$V_{CC} = \text{MAX}, V_I = 0.4 \text{ V}$				-0.4			-0.4	mA
	CLR or CLK					-0.8			-0.8	
$I_{OS}§$		$V_{CC} = \text{MAX},$ See Note 4		-20		-100	-20		-100	mA
I_{CC}		$V_{CC} = \text{MAX},$ See Note 2			4	6		4	6	mA

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values are at $V_{CC} = 5 \text{ V}, T_A = 25^\circ\text{C}$.

§ Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second.

NOTE 2: With all outputs open, I_{CC} is measured with the Q and $\bar{Q}$ outputs high in turn. At the time of measurement, the clock input is grounded.

NOTE 4: For certain devices where state commutation can be caused by shorting an output to ground, an equivalent test may be performed with $V_O = 2.25 \text{ V}$ and 2.125 V for the 54 family and the 74 family, respectively, with the minimum and maximum limits reduced to one half of their stated values.

switching characteristics, $V_{CC} = 5 \text{ V}, T_A = 25^\circ\text{C}$ (see note 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS		MIN	TYP	MAX	UNIT
f_{max}			$R_L = 2\text{ k}\Omega$, $C_L = 15\text{ pF}$		30	45		MHz
t_{PLH}	$\overline{CLR}$ or CLK	Q or $\overline{Q}$				15	20	ns
t_{PHL}						15	20	ns

NOTE 3: See General Information Section for load circuits and voltage waveforms

